

**Search Notes**

Application/Control No.

10/067,981

Examiner

Jacob Meek

Applicant(s)/Patent under  
Reexamination

OHSAWA, SUSUMU

Art Unit

2637

**SEARCHED**

Class	Subclass	Date	Examiner
375	267,224 316,317	12/14/2005	JM
455	134,275	12/14/2005	JM
455	277.2,61	12/14/2005	JM
455	101,133	12/14/2005	JM
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455	278.1,303	12/14/2005	JM
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455	190.1,506	12/14/2005	JM
455	277.1 13.2	12/14/2005	JM
455	276.1	12/14/2005	JM
370	320	12/14/2005	JM
714	724,822	12/14/2005	JM

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: see search notes	12/14/2005	JM
Per Ed Urban search 455/273,276.1,278.1	12/5/2005	JM